

Improve of Efficiency in Silicon Thin-Film Solar Cells by Optimizing Front TCO and Back Reflector

Sang Won Jeon^{1,2}, Jeong Chul Lee¹, Sae Jin Ahn¹, Jae Ho Yun¹, Seok Ki Kim¹, Jinsoo Song¹,
Byung Ok Park² and Kyung Hoon Yoon^{1*}

¹Solar Cells Research Center, Korea Institute of Energy Research (KIER)

71-2, Jang-dong, Yuseong-gu, Daejeon 305-343, Korea

* Tel. +82-42-860-3191, Fax. +82-42-860-3739, e-mail : y-kh@kier.re.kr

²Dept. of Inorganic Materials Science Engineering, Kyungpook National University, Korea

The surface textured ZnO:Al TCO(Transparent Conducting Oxide) films has been considered to be one of the most significant parameters for improving device quality of microcrystalline silicon($\mu\text{C-Si:H}$) thin-film solar cells. Since the thickness of light absorbing layer in a pin $\mu\text{C-Si:H}$ thin-film solar cell is very thin (less than $5\ \mu\text{m}$), the light trapping within the intrinsic absorbing layer by front TCO and back reflection layer(usually back contact) should be maximized in order to increase the generation of electron-hole pairs. The front ZnO:Al films act as scattering incident light, by which the travel length of incident light is prolonged within the light absorbing layer. The ZnO layer as a back reflector with metal electrodes (Ag or Al) has low absorption in order to provide enhanced internal reflection of light that does not absorbed to thin-film silicon active layer.

In this paper, ZnO:Al films are prepared by rf magnetron sputtering method on glass substrate and chemically etched in 1% HCl solution to make rough surface. The Ar pressure and substrate temperature are dominant parameters both to determine electro-optical properties of as-deposited ZnO:Al films and to control surface morphology of chemically etched films. The operation properties of $\mu\text{C-Si:H}$ thin-film solar cells prepared on ZnO:Al films with various surface morphologies are discussed with etching behavior with different sputtering conditions. And various back reflectors was incorporated to find optimum light trapping for silicon based thin-film solar cells.